PATENT

DT05 Rec'd PCT/PTO 1 0 DEC 2004

Docket No.: GAS-002

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Inventor(s): Jurgen SCHULEIN et al.

Confirmation No.

U.S. Patent Application No.: Not yet assigned

Group Art Unit: Not yet assigned

Filed: Herewith

DEVICE AND METHOD FOR ELECTROCHEMICAL DETECTION

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed with the application and no certification or fee is required.

Please note this is a PCT application in the entry of the National Phase in the U.S. and copies of the references cited were transmitted by WIPO and are believed to be in the file of the above-identified application and readily available to the Examiner. Therefore it is believed that Applicants have met all requirements regarding duty of disclosure under 37 CFR 1.56. A copy of the foreign search report is attached for the Examiner's information. Acknowledgement and consideration of these documents are respectfully requested.

Respectfully submitted,

HAUPTMAN KANESAKA BERNER Patent Agents, LLP

Manabu Kanesaka

Registration No. 31,467

1700 Diagonal Road, Suite 300 Alexandria, Virginia 22314

(703) 519-9785

Facsimile: (703) 519-7769

Date: December 10, 2004

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U.S. APPLICATION NO. ATTY. DOCKET NO. INFORMATION DISCLOSURE GAS-002 Not yet assigned CITATION IN AN APPLICANT: Jurgen SCHULEIN et al. APPLICATION FILING DATE **GROUP** herewith (PTO-1449) U.S. PATENT DOCUMENTS FILING **EXAMINER'S** INITIALS **CLASS SUBCLASS** PATENT NO. DATE NAME DATE 08/01/1983 4,655,880 04/07/1987 Liu 03/12/1999 2001/0029048 10/11/2001 Ding et al 5,149,629 09/22/1992 Rishpon et al 04/04/1988 08/14/1980 02/16/1982 Bruckenstein et al 4,315,753 09/04/1991 06/08/1993 Almon 5,217,112 FOREIGN PATENT DOCUMENTS **EXAMINER'S** PATENT NO. COUNTRY **CLASS SUBCLASS** DATE INITIALS OTHER ART (Including Author Title, Date, Pertinent Pages, Etc.)

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

EXAMINER

DATE CONSIDERED